

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10581481	IKEDA ET AL.
<b>Examiner</b>		<b>Art Unit</b>
YUK CHOW		2629

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	107	9/28/2009	yc
359	296	9/28/2009	yc
313	498	9/28/2009	yc

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST:electrophoretic particles, partition wall, recess portion. new ref read on claims, narrowing partition wall read on recess portion.	9/28/2009	yc
	5/7/2010	yc

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>